 Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 12732-221001	Application No. 10/801,135
	Applicant Shunpei Yamazaki et al.			
	Filing Date March 16, 2004		Group Art Unit 2811	

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

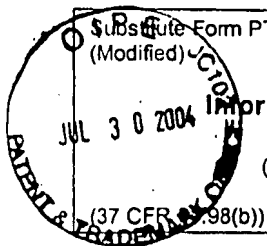
Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
LS	AL	JP3408154	19 MAY 2003	JAPAN			Full	
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature /Leonid Shapiro/	Date Considered 01/10/2007
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	


 Substitute Form PTO-1449
(Modified)

 U.S. Department of Commerce
Patent and Trademark Office

 Attorney's Docket No.
12732-221001

 Application No.
10/801,135

**Information Disclosure Statement
by Applicant**

(Use several sheets if necessary)

 Applicant
Shunpei Yamazaki et al.

 Filing Date
March 16, 2004

 Group Art Unit
2811

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
LS	AL	3408154	03/14/2003	JAPAN			ABS	
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
LS	AQ	Exhibition of Active Matrix Type Organic EL Display at "13 th Flat Panel Display Manufacturing Technology Expo & Conference" by ELDIS Group (<i>in Japanese with full translation</i>); July 2, 2003
LS	AR	Documents distributed in the "13 th Flat Panel Display Manufacturing Technology Expo & Conference" by ELDIS Group (5 pages)
LS	AS	"Two-way display developed"; <i>The Japan Times</i> ; (1 page); July 3, 2003
LS	AT	"Mass Production of Organic EL Devices"; <i>Shimotsuke Newspaper</i> (<i>in Japanese with full translation</i>); July 3, 2003

Examiner Signature

. /Leonid Shapiro/

Date Considered

01/10/2007

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-221001	Application No. New Application
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Shunpei Yamazaki et al.	
		Filing Date March 16, 2004	Group Art Unit

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
LS	AL	2000-215295	08/04/2000	JAPAN			ABS	
LS	AM	2002-258975	09/13/2002	JAPAN			ABS	
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature /Leonid Shapiro/	Date Considered 01/10/2007
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	